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PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Serial No.: 10/718,554

Confirmation No.: 1824

In re Application of:

Tetsuya SATOU et al.

Group Art Unit: 1774

Filed: November 24, 2003

Examiner: Marie Rose Yamnitzky

For: THIN FILM EL DEVICE

TRANSMITTAL OF CORRECTED PTO-1449

Commissioner for Patents  
P. O. Box 1450  
Alexandria, Virginia 22313-1450

Sir:

The PTO-1449 accompanying the Information Disclosure Statement filed August 6, 2004 contained errors in identifying the second and third references. A corrected PTO-1449 is enclosed herewith. The oversight is regretted.

Respectfully submitted,

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*September 16, 2004*

Date

CAW/ch

Attorney Docket No.: OGOH:089A

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FORM PTO 1449 (modified)

U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICELIST OF REFERENCES CITED BY APPLICANT(S)  
(Use several sheets if necessary)ATTY DOCKET NO.  
OGOH:089A

SEP 16 2004

SERIAL NO.  
10/718,554APPLICANT  
Tetsuya SATOU et al.FILING DATE  
November 24, 2003GROUP  
1774

## U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	6,541,129 B1	4/1/03	Kawamura et al.	428	690	
	2003/0143430 A1	7/31/03	Kawamura et al.	428	690	
	2003/0207153 A1	11/6/03	Senoo et al.	428	690	
	6,280,859 B1	8/28/01	Onikubo et al.	428	690	
	2001/0033944 A1	10/25/01	Onikubo et al.	428	690	
	5,792,557	8/11/98	Nakaya et al.	428	411.1	

## FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION NO YES	
	6-240245	8/30/94	Japan (w/Abstract)			X	
	2000-309566	11/7/00	Japan (w/corresponding US patents)			X	
	2000-16973	1/18/00	Japan (w/corresponding US patent)			X	
	7-188130	7/25/95	Japan (w/Abstract)			X	
	10-251633	9/22/98	Japan (w/corresponding US patents)			X	
	8-48656	2/20/96	Japan (w/corresponding US patent)			X	

## OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)


EXAMINER

DATE CONSIDERED

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.